
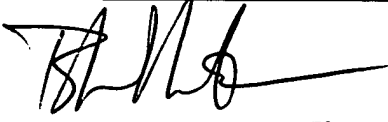



<b>Issue Classification</b> 	Application No.	Applicant(s)	
	09/784,503	SLATTER, DAVID NEIL	
	Examiner	Art Unit	
	Duy M Dang	2621	

ISSUE CLASSIFICATION									
ORIGINAL				CROSS REFERENCE(S)					
CLASS		SUBCLASS		CLASS	SUBCLASS (ONE SUBCLASS PER BLOCK)				
382		284		382	294				
INTERNATIONAL CLASSIFICATION				358	450				
G	0	6	K		9136				
G	0	6	K		9132				
H	0	4	N		11387				
					/				
					/				

Duy M. Dang (Assistant Examiner) (Date)		 <b>BHAVESH M. MEHTA</b> (Patent Examiner) (Date) <b>SUPERVISORY PATENT EXAMINER</b> <b>TECHNOLOGY CENTER 2600</b>	Total Claims Allowed: 13	
 (Legal Instruments Examiner) (Date)			O.G. Print Claim(s) 1	O.G. Print Fig. 1

<input type="checkbox"/> Claims renumbered in the same order as presented by applicant				<input type="checkbox"/> CPA				<input type="checkbox"/> T.D.				<input type="checkbox"/> R.1.47			
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